

MBL1200F17F

Silicon N-channel IGBT 1700V F version

FEATURES

- * Soft switching behavior & low conduction loss :
Soft low-injection punch-through with trench gate IGBT
- * Low driving power due to low input capacitance advanced trench gate.
- * Low noise due to ultra soft fast recovery diode.
- * High Current rate Package.
- * Low $R_{th(j-c)}$ & low stray inductance.
- * RoHS

ABSOLUTE MAXIMUM RATINGS ($T_C=25^{\circ}\text{C}$)

Item	Symbol	Unit	MBL1200F17F
Collector Emitter Voltage	V_{CES}	V	1,700
Gate Emitter Voltage	V_{GES}	V	± 20
Collector Current	DC	A	1,200
	1ms		2,400
Forward Current (Free wheel Diode) (1)	DC	A	150
	1ms		300
Forward Current (Chopper Diode)	DC	A	1,200
	1ms		2,400
Operating Junction Temperature	$T_{vj\text{ op}}$	$^{\circ}\text{C}$	-50 ~ +150
Storage Temperature	T_{stg}	$^{\circ}\text{C}$	-50 ~ +150
Isolation Voltage	V_{ISO}	V_{RMS}	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	N·m	2/15 (2)
	Mounting (M6)		6 (3)

Notes: (1) For reverse voltage protection (2) Recommended Value $1.8 \pm 0.2 / 15^{+0}_{-3} \text{N}\cdot\text{m}$ (3) Recommended Value $5.5 \pm 0.5 \text{N}\cdot\text{m}$

ELECTRICAL CHARACTERISTICS

1) IGBT+FWD

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I_{CES}	mA	-	-	4	$V_{CE}=1,700\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=25^{\circ}\text{C}$
Gate Emitter Leakage Current	I_{GES}	nA	-500	-	+500	$V_{CE}=1,700\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=150^{\circ}\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	-	1.9	-	$I_C=1,200\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=25^{\circ}\text{C}$
			-	2.3	2.6	$I_C=1,200\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=150^{\circ}\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(th)}$	V	4.1	5.5	7.1	$V_{CE}=10\text{V}$, $I_C=120\text{mA}$, $T_{vj}=25^{\circ}\text{C}$
Input Capacitance	C_{ies}	nF	-	63	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_{vj}=25^{\circ}\text{C}$
Internal Gate Resistance	$R_{G(int)}$	Ω	-	2.9	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_{vj}=25^{\circ}\text{C}$
Turn On Delay Time	$t_{d(on)}$	μs	-	0.78	-	$V_{CC}=900\text{V}$, $I_C=1,200\text{A}$
Rise Time	t_r		-	0.25	-	$L_S=115\text{nH}$ (4)
Turn Off Delay Time	$t_{d(off)}$		-	1.7	-	$R_{G(on/off)}=6.8/6.8\Omega$ (4)
Fall Time	t_f		-	1.3	-	$V_{GE}=\pm 15\text{V}$, $T_{vj}=150^{\circ}\text{C}$
Forward Voltage Drop	V_F	V	-	1.5	-	$I_F=150\text{A}$, $V_{GE}=0\text{V}$, $T_{vj}=25^{\circ}\text{C}$
			-	1.6	-	$I_F=150\text{A}$, $V_{GE}=0\text{V}$, $T_{vj}=150^{\circ}\text{C}$
Turn On Loss	E_{on}	J/P	-	0.58	-	$V_{CC}=900\text{V}$, $I_C=1,200\text{A}$ $L_S=115\text{nH}$ (4)
Turn Off Loss	E_{off}	J/P	-	0.9	-	$R_{G(on/off)}=6.8/6.8\Omega$ (4) $V_{GE}=\pm 15\text{V}$, $T_{vj}=150^{\circ}\text{C}$
Stray inductance module	L_{SCE}	nH	-	20	-	Collector Main to Emitter Main
Thermal Impedance	IGBT	K/W	-	-	0.02	Junction to case
	FWD		-	-	0.13	
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.016	-	Case to fin (grease= $1\text{W}/(\text{m}\cdot\text{K})$), (at IGBT+FWD part)

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2) Chopper Diode

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Repetitive Reverse Current	I_{RRM}	mA	-	-	2	$V_{CE}=1,700V, T_{vj}=25^{\circ}C$
			-	8	-	$V_{CE}=1,700V, T_{vj}=150^{\circ}C$
Forward Voltage Drop (Between main terminals)	V_F	V	-	2.1	-	$I_F=1,200A, T_{vj}=25^{\circ}C$ Measured at main terminals
			-	2.3	-	$I_F=1,200A, T_{vj}=150^{\circ}C$ Measured at main terminals
Reverse Recovery Time	t_{rr}	μs	-	1.6	-	$V_{CC}=900V, I_F=1,200A$ $L_S=115nH$ (4)
Reverse Recovery Loss	E_{rr}	J/P	-	0.35	-	$R_G(\text{on/off})=6.8/6.8\Omega$ (4) $V_{GE}=\pm 15V, T_{vj}=150^{\circ}C$
Thermal Impedance	$R_{th(j-c)}$	K/W	-	-	0.03	Junction to case
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.016	-	Case to fin(at Chopper Diode part)

Notes:(4) L_S and R_G are the test condition's values for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

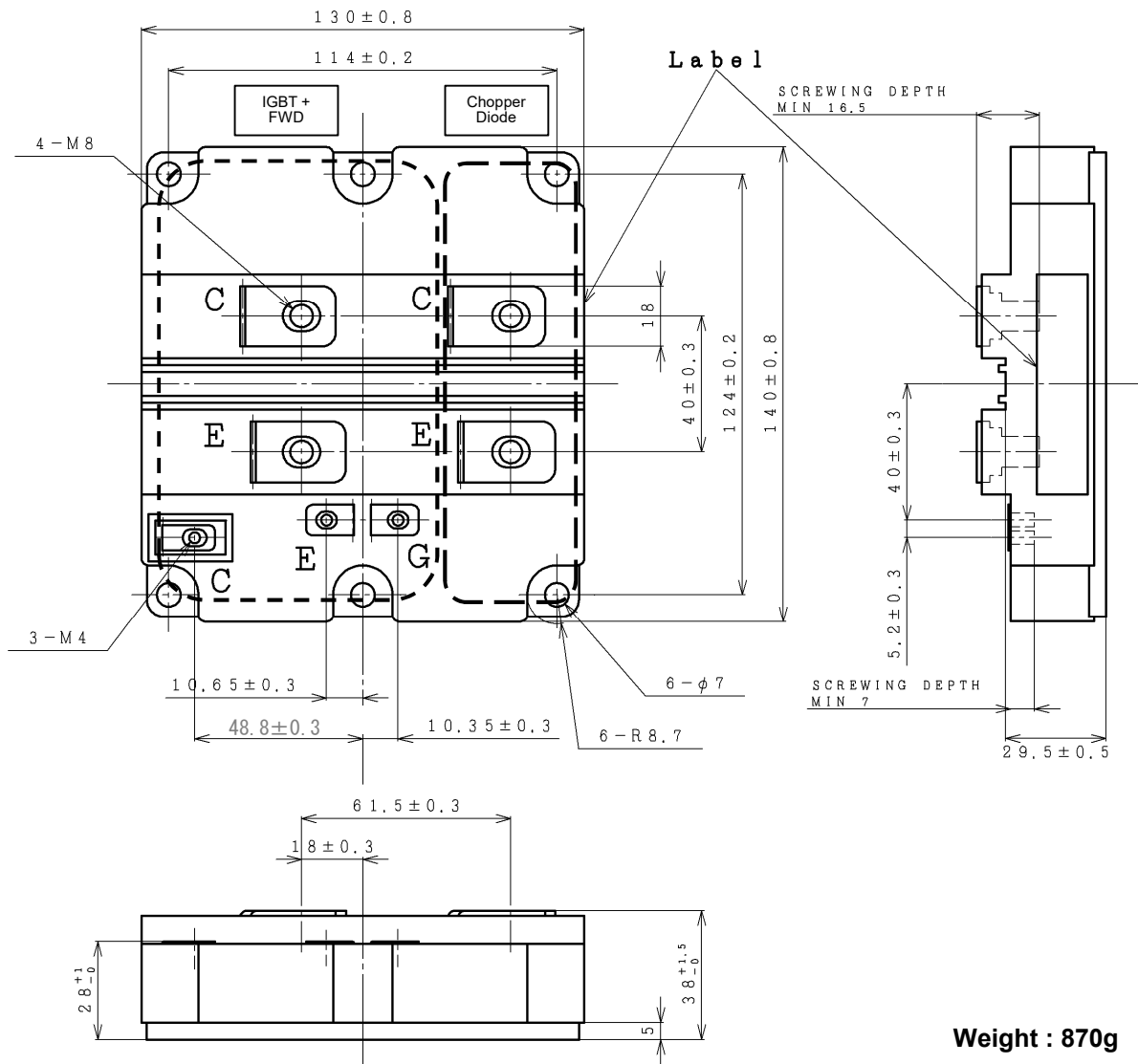
* For actual application, please confirm this spec sheet is the newest revision.

* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747-2 and IEC 60747-9.

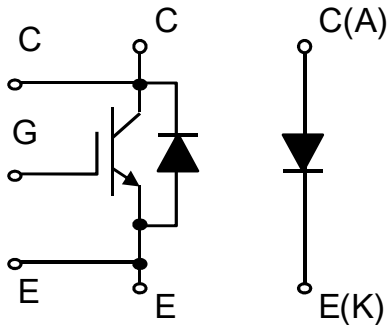
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OUTLINE DRAWING

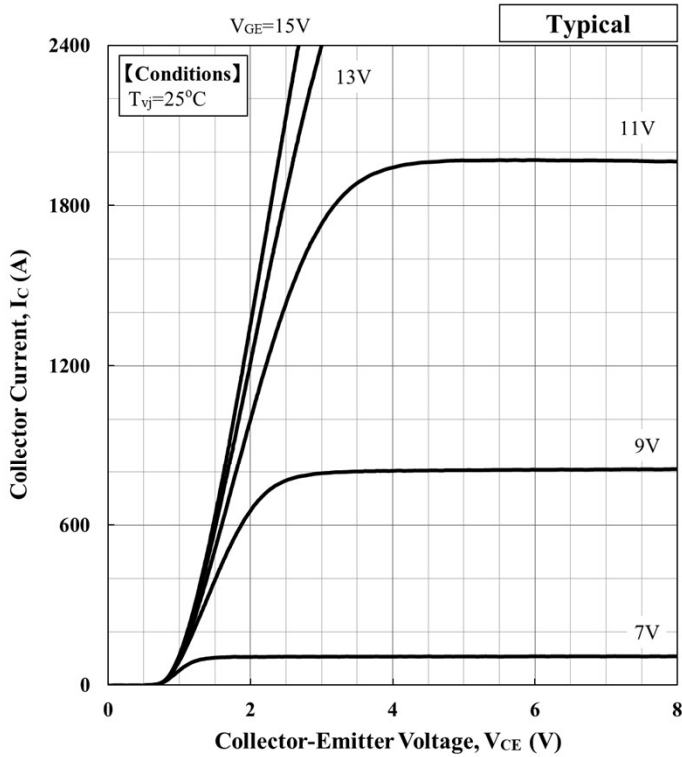
Unit in mm



CIRCUIT DIAGRAM



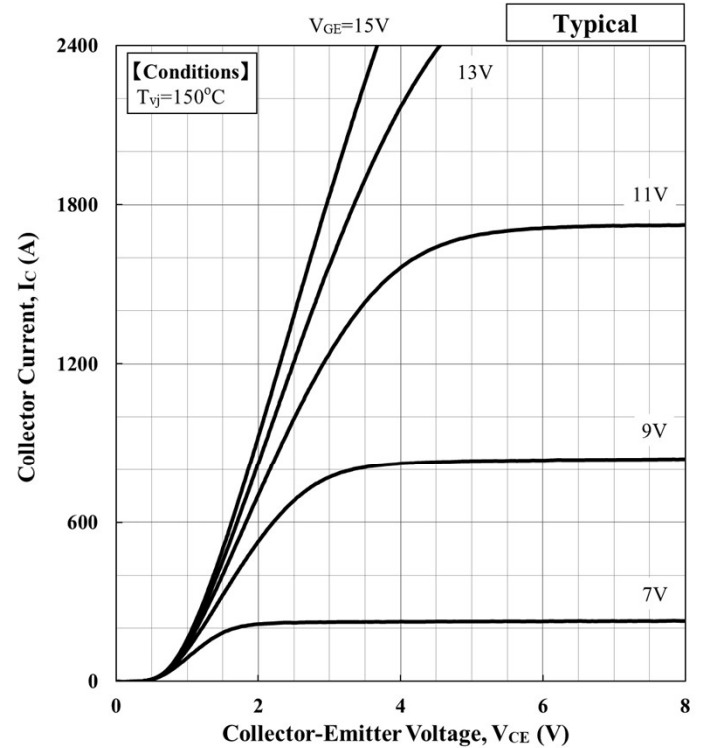
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$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	$V_{GE}[V]$	a_3	a_2	a_1	a_0
25	15	6.04.E-11	-2.92.E-07	1.09.E-03	9.07.E-01

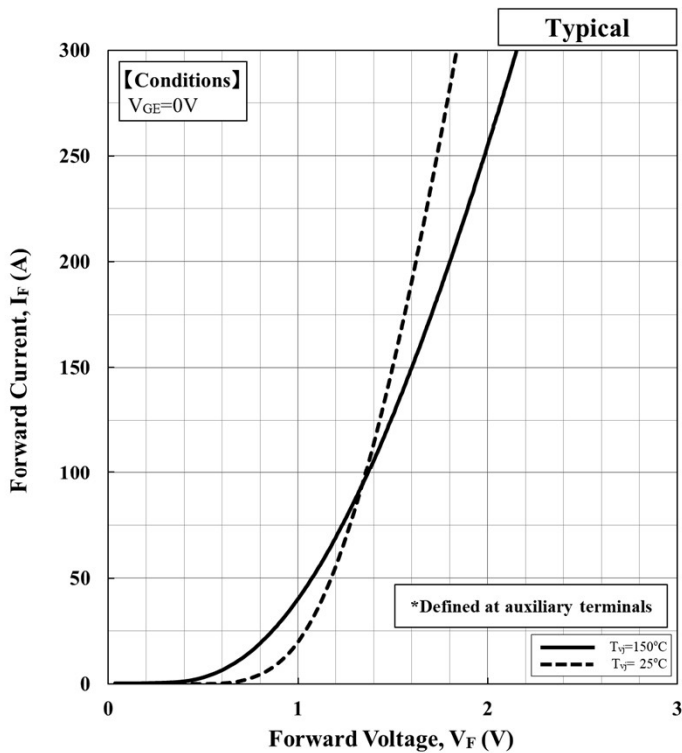
Collector Current vs. Collector Emitter Voltage



$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	$V_{GE}[V]$	a_3	a_2	a_1	a_0
150	15	9.52.E-11	-4.02.E-07	1.63.E-03	7.66.E-01

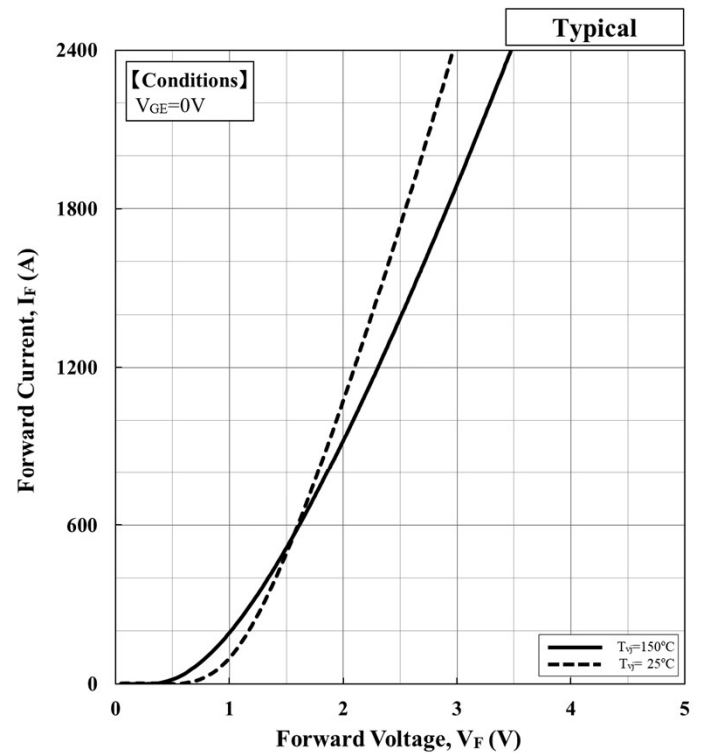
Collector Current vs. Collector Emitter Voltage



$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

Temp.[°C]	a_3	a_2	a_1	a_0
25	2.77.E-08	-1.86.E-05	6.27.E-03	8.91.E-01
150	3.98.E-08	-2.70.E-05	9.59.E-03	6.43.E-01

Forward Voltage of free-wheeling diode

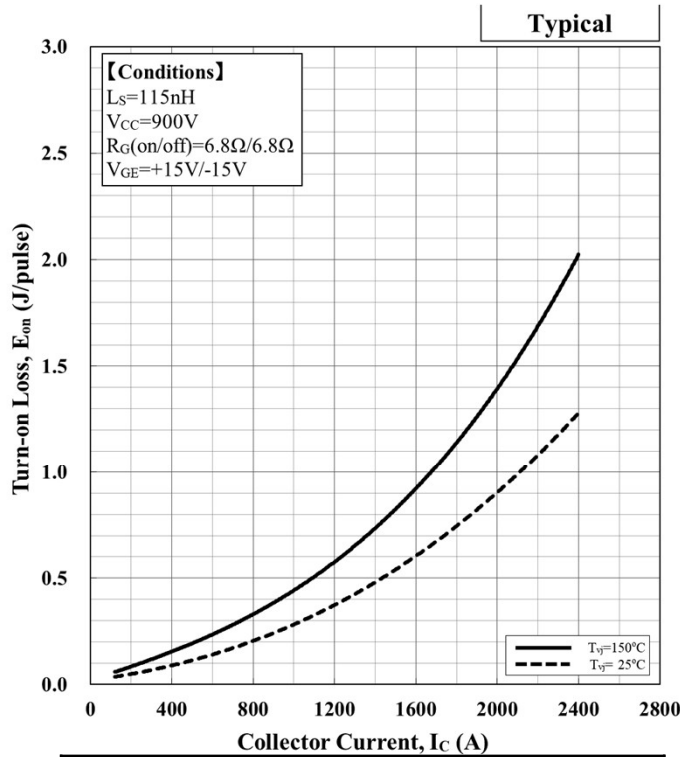


$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

Temp.[°C]	a_3	a_2	a_1	a_0
25	5.93.E-11	-3.20.E-07	1.28.E-03	9.30.E-01
150	8.33.E-11	-4.62.E-07	1.80.E-03	6.70.E-01

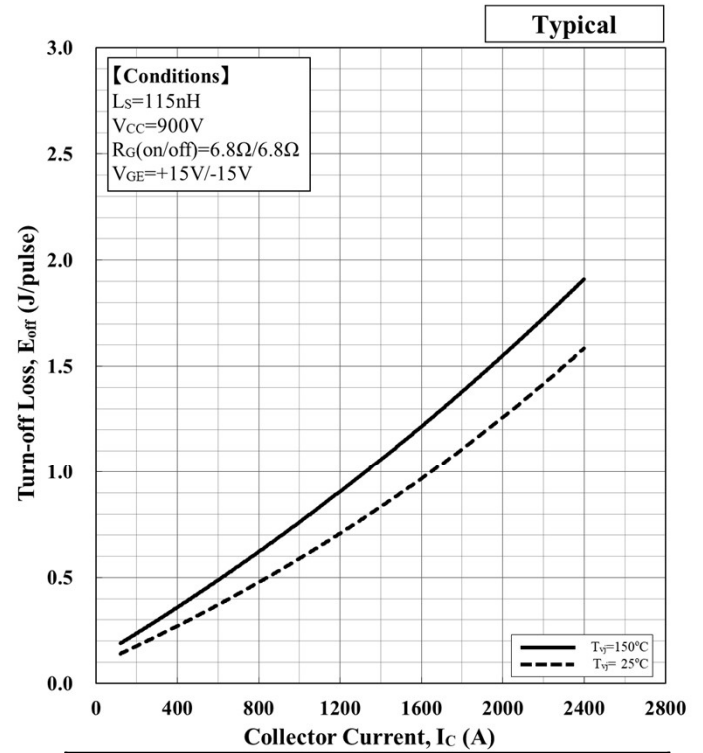
Forward Voltage of Chopper diode

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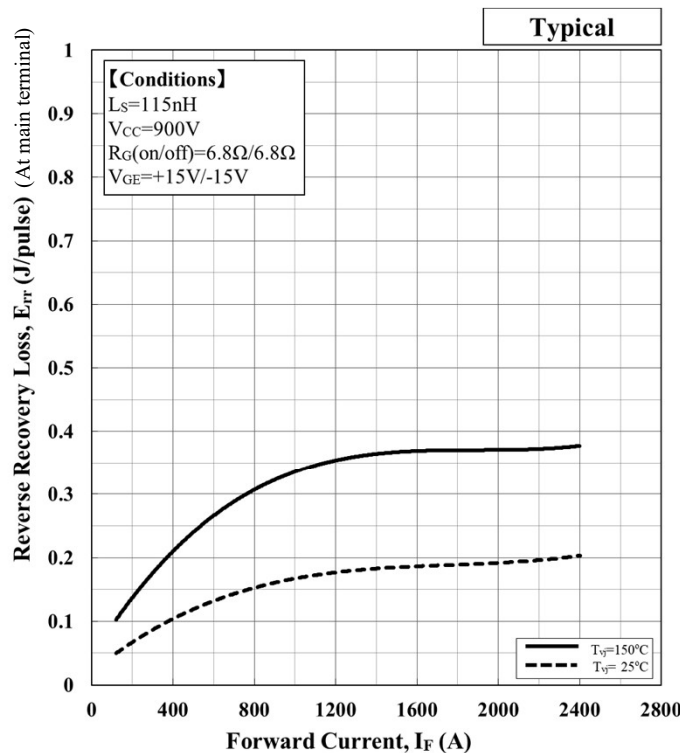
$E [J] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$				
Temp.[°C]	a_3	a_2	a_1	a_0
25	2.10E-11	1.16E-07	1.26E-04	1.91E-02
150	7.39E-11	4.36E-08	3.04E-04	2.14E-02

Turn-on loss vs. Collector current



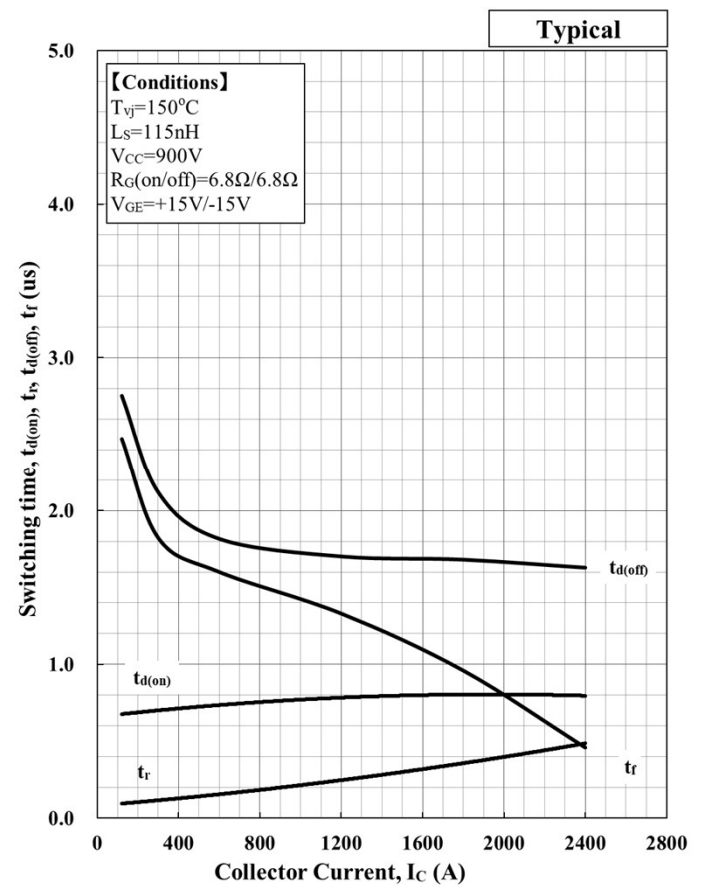
$E [J] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$				
Temp.[°C]	a_3	a_2	a_1	a_0
25	8.62E-12	5.79E-08	4.35E-04	8.77E-02
150	2.02E-12	6.80E-08	5.71E-04	1.20E-01

Turn-off loss vs. Collector current



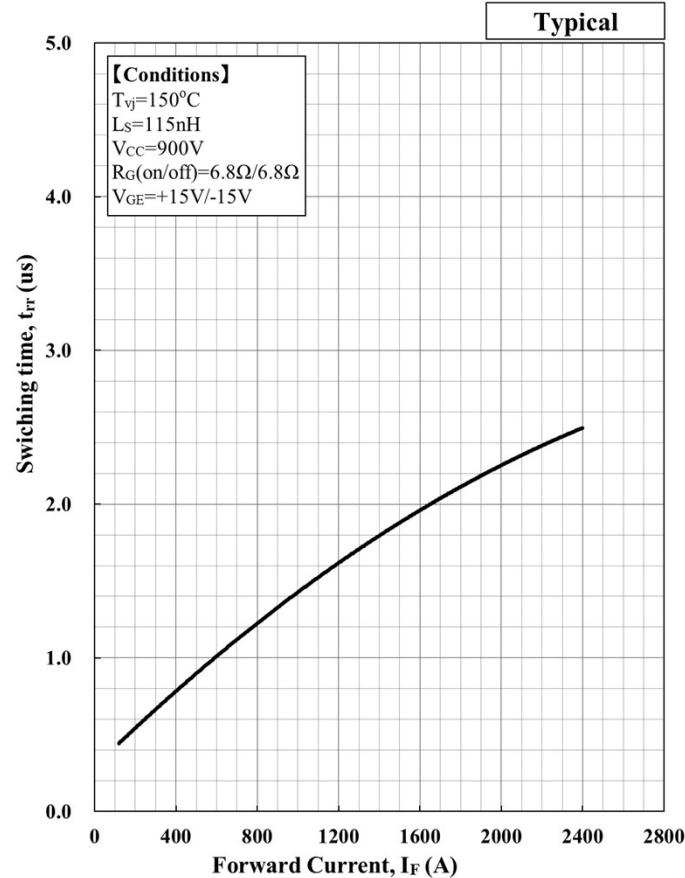
$E [J] = a_3 \cdot I_F ^3 + a_2 \cdot I_F ^2 + a_1 \cdot I_F + a_0$				
Temp.[°C]	a_3	a_2	a_1	a_0
25	2.66E-11	-1.41E-07	2.61E-04	2.04E-02
150	4.78E-11	-2.71E-07	5.15E-04	4.45E-02

Recovery loss vs. Forward Current(Chopper Diode)



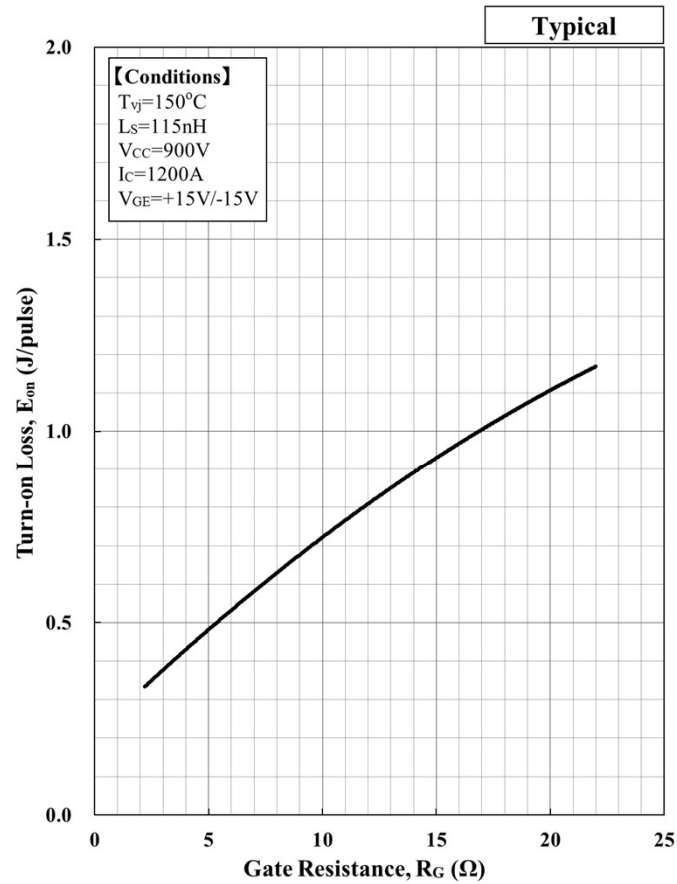
Switching time vs. Collector Current

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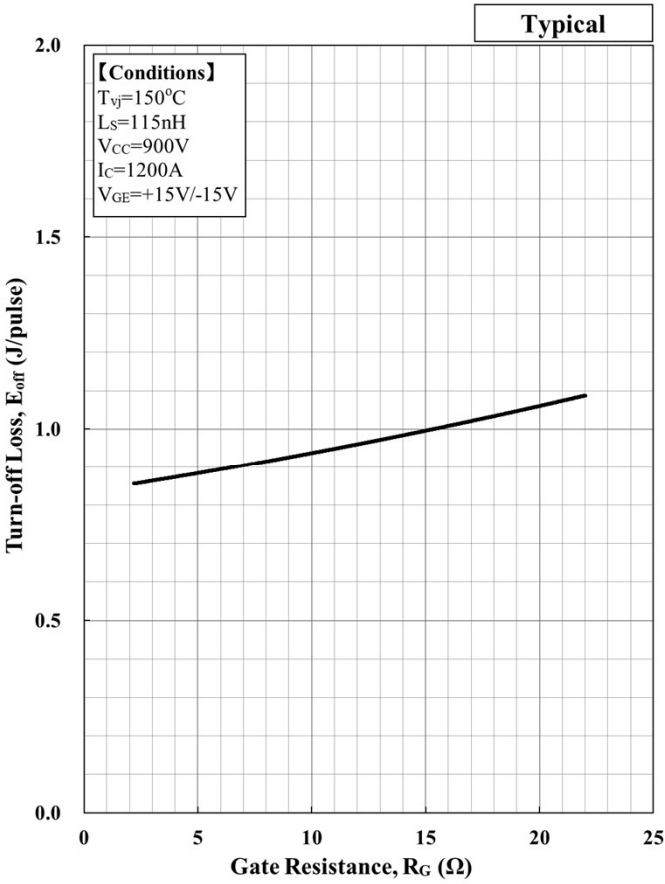


Switching time vs. Forward Current of chopper diode

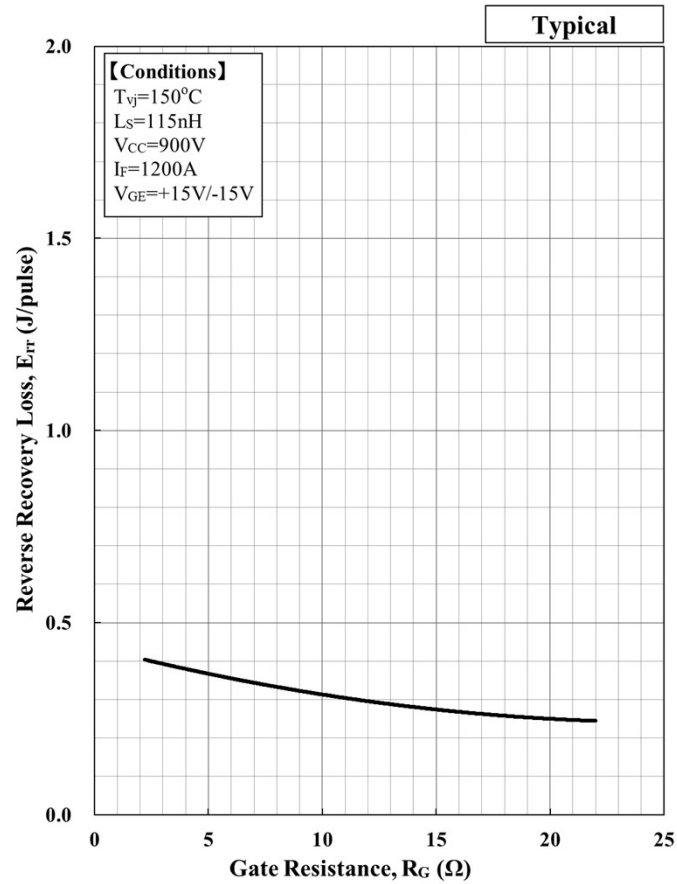
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Turn-on loss vs. Gate Resistance

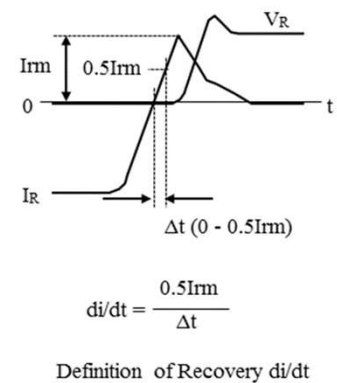
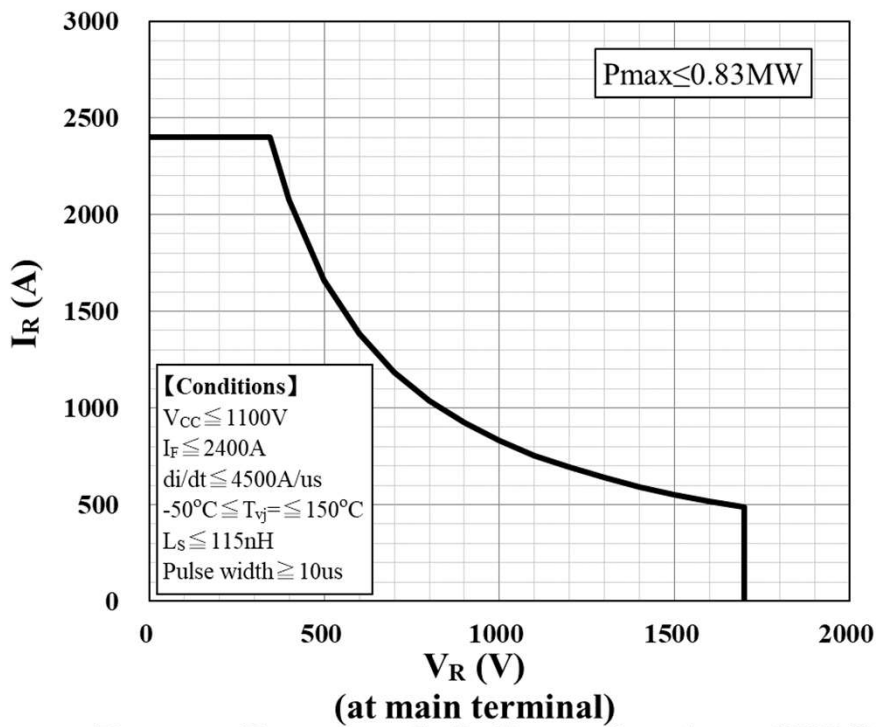
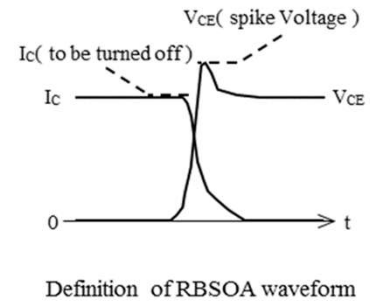
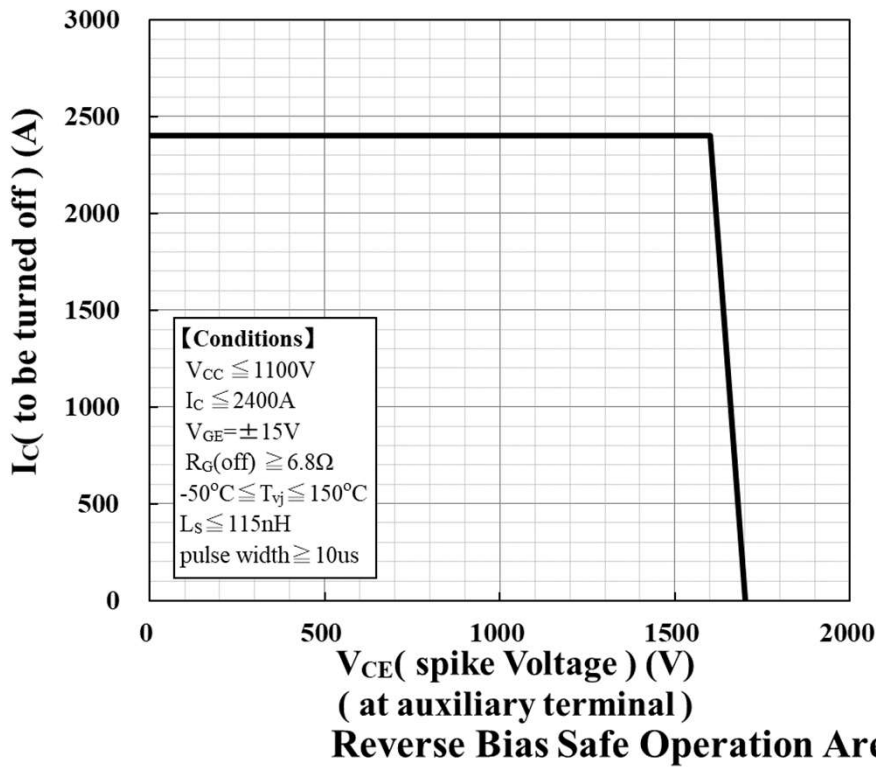


Turn-off loss vs. Gate Resistance

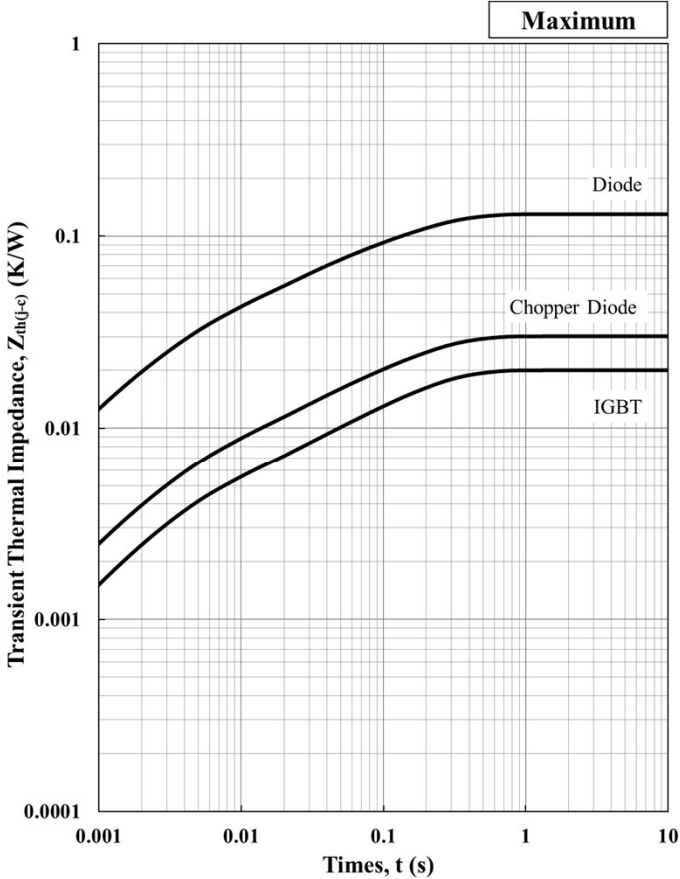
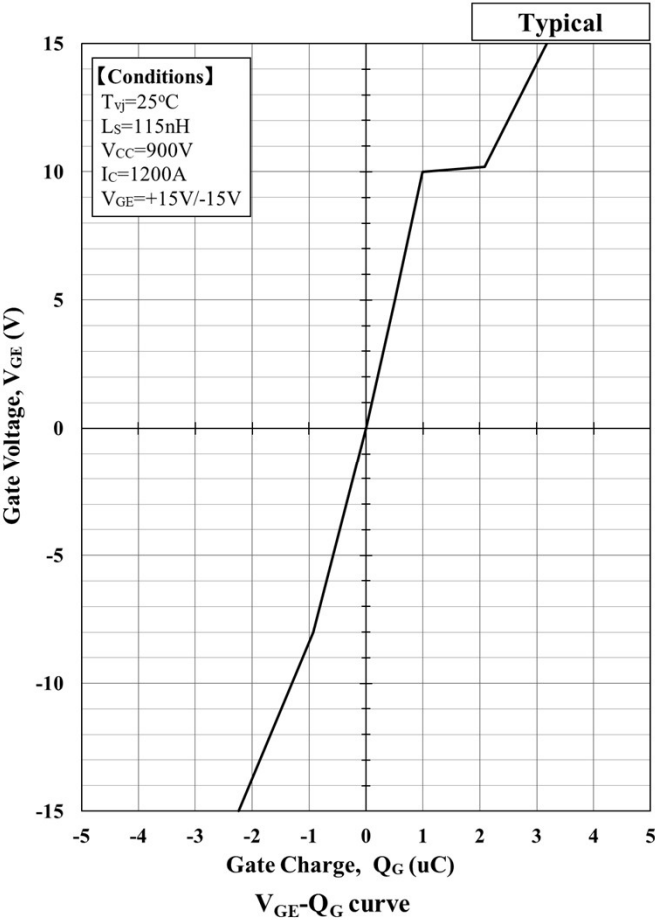


Recovery loss vs. Gate Resistance

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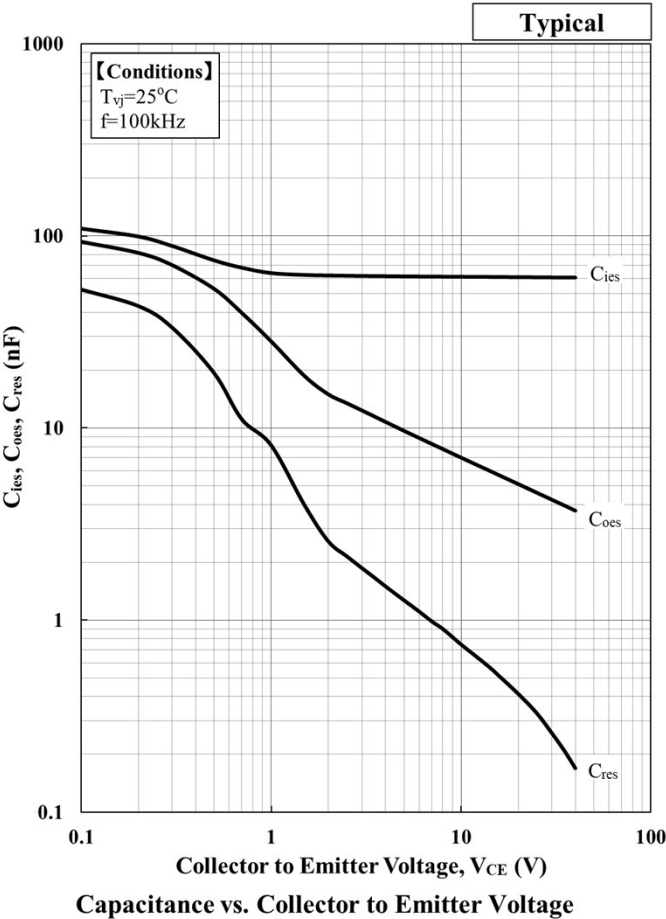
Transient Thermal Impedance Curve

Foster model lumped circuit constant

N	1	2	3	4	Unit
R th, IGBT [n]	1.29E-02	3.34E-03	3.36E-03	4.62E-04	[K/W]
C th, IGBT [n]	1.26E+01	7.45E+00	9.35E-01	1.17E+00	[J/K]
R th, Diode [n]	6.80E-02	3.29E-02	2.39E-02	5.27E-03	[K/W]
C th, Diode [n]	2.39E+00	7.56E-01	1.32E-01	1.03E-01	[J/K]
R th, Chopper Diode [n]	1.79E-02	6.21E-03	5.06E-03	8.91E-04	[K/W]
C th, Chopper Diode [n]	9.07E+00	4.00E+00	6.21E-01	6.07E-01	[J/K]

Cauer model lumped circuit constant

n	1	2	3	4	Unit
R th, IGBT [n]	2.37E-03	3.08E-03	6.69E-03	7.88E-03	[K/W]
C th, IGBT [n]	4.68E-01	6.27E-01	4.67E+00	1.30E+01	[J/K]
R th, Diode [n]	1.78E-02	2.46E-02	4.38E-02	4.38E-02	[K/W]
C th, Diode [n]	5.24E-02	9.55E-02	5.87E-01	2.79E+00	[J/K]
R th, Chopper Diode [n]	3.67E-03	5.04E-03	1.01E-02	1.13E-02	[K/W]
C th, Chopper Diode [n]	2.76E-01	4.28E-01	2.78E+00	9.94E+00	[J/K]



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